Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/705,818	NAKAYAMA ET AL.		
Examiner	Art Unit		
Chuck Huynh	2617		

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Search	7/10/2006	at		
455	411	7/10/2006	ar		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Class/Subclass	7/10/2006	ar	
IDS	7/10/2006	4-	
Combined Text Search: class 455/411 + charge + value + entity	7/11/2006	4	